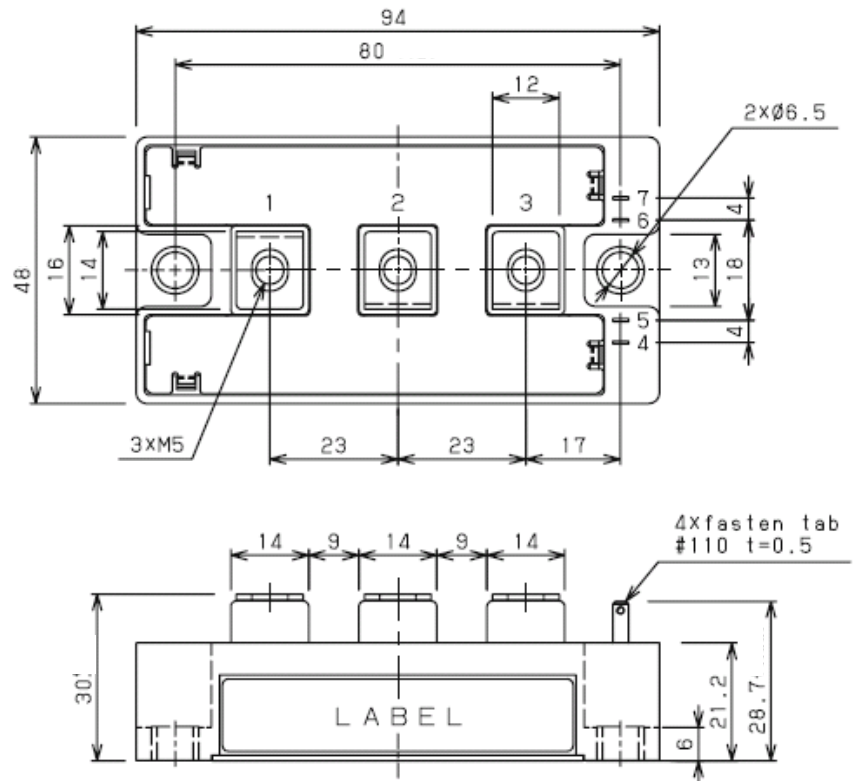
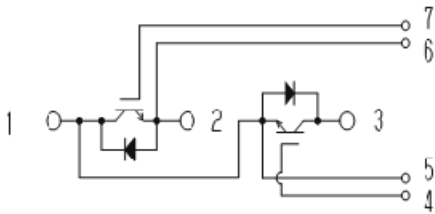


□ 回路図 : *CIRCUIT*

 □ 概略図 : *SCHEMATIC DIAGRAM*

Dimension: [mm]


 □ 最大定格 : *MAXIMUM RATINGS* (at $T_c=25^\circ\text{C}$ unless otherwise specified)

Item		Symbol	Condition	Rated Value	Unit
IGBT	コレクタ・エミッタ間電圧 Collector-Emitter Voltage	V_{CES}	G-E Short	650	V
	ゲート・エミッタ間電圧 Gate-Emitter Voltage	V_{GES}	C-E Short	± 20	V
	コレクタ電流 Collector Current	I_C	DC $T_c=85^\circ\text{C}$	300	A
		I_{CP}	Pulse $\leq 1\text{ms}$	600	
コレクタ損失 Collector Power Dissipation	P_C	$T_j=175^\circ\text{C}$	1153	W	
		$T_j=150^\circ\text{C}$	961		
FWD	繰り返しピーク逆電圧 Repetitive peak reverse voltage	V_{RRM}		650	V
	順電流 Forward Current	I_F		300	A
		I_{FM}	Pulse $\leq 1\text{ms}$	600	
最大接合温度 Maximum Junction Temperature		T_{jMAX}	瞬時動作(過負荷) Instantaneous Overload	175	$^\circ\text{C}$
接合温度範囲 Junction Temperature Range		T_j		$-40 \sim +150$	$^\circ\text{C}$
保存温度範囲 Storage Temperature Range		T_{stg}		$-40 \sim +125$	$^\circ\text{C}$
絶縁耐圧 Isolation Voltage		V_{ISO}	Terminal to Base AC, 1minute	2,500	V (RMS)
締め付けトルク Mounting Torque	Module Base to Heatsink	F_{tor}	M6	3	N · m
	Busbar to Main Terminal		M5	2	

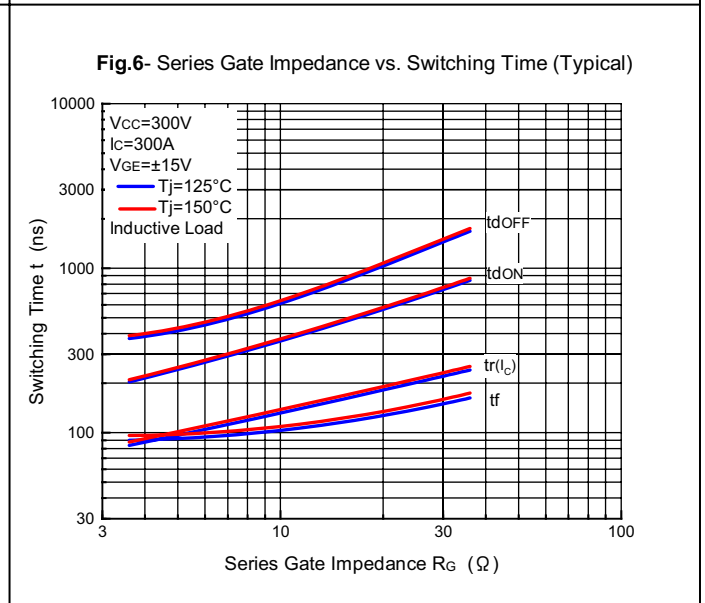
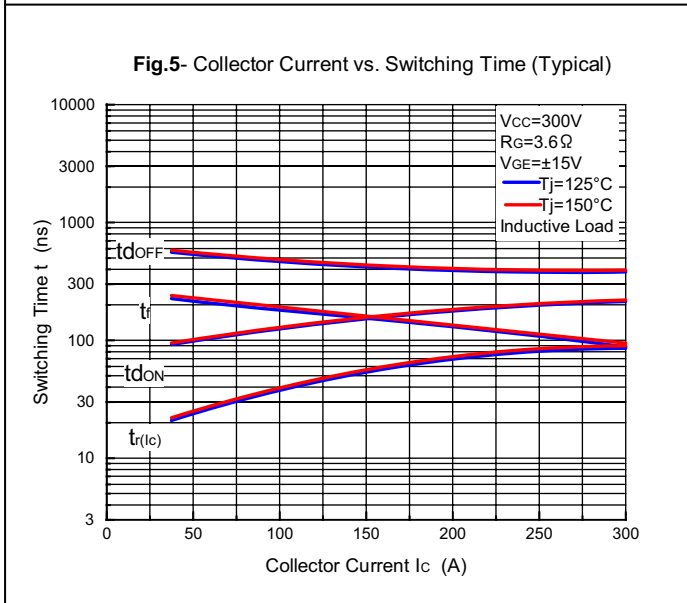
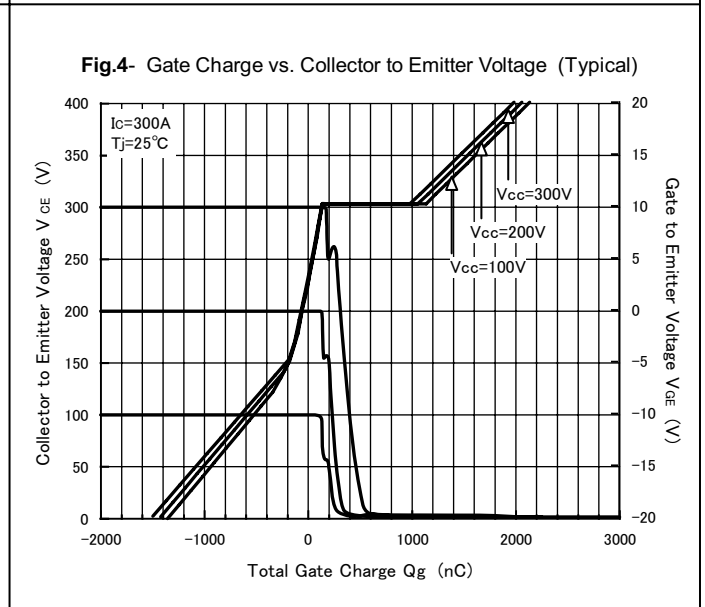
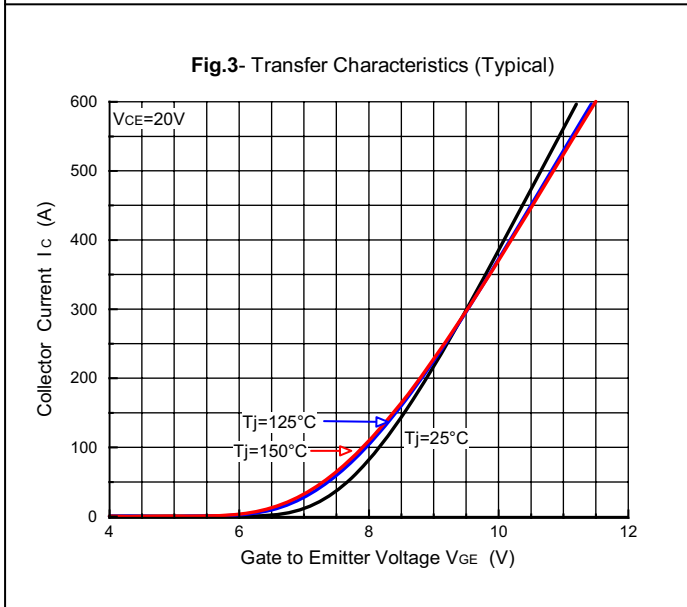
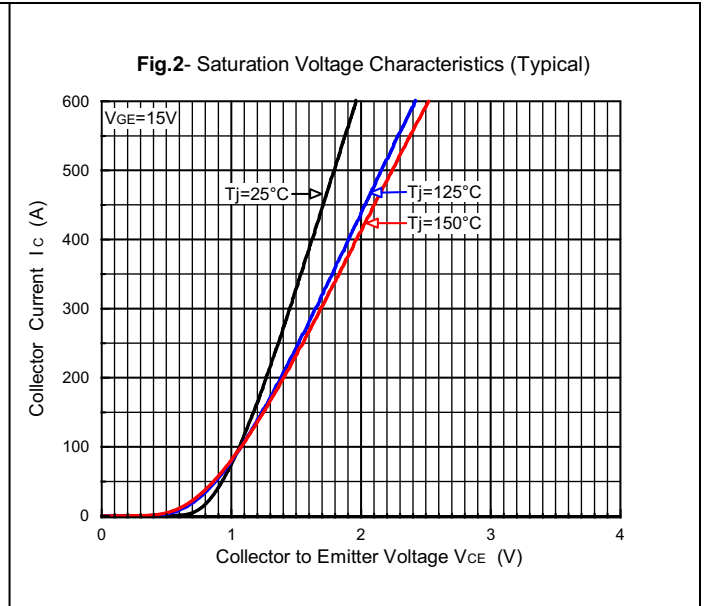
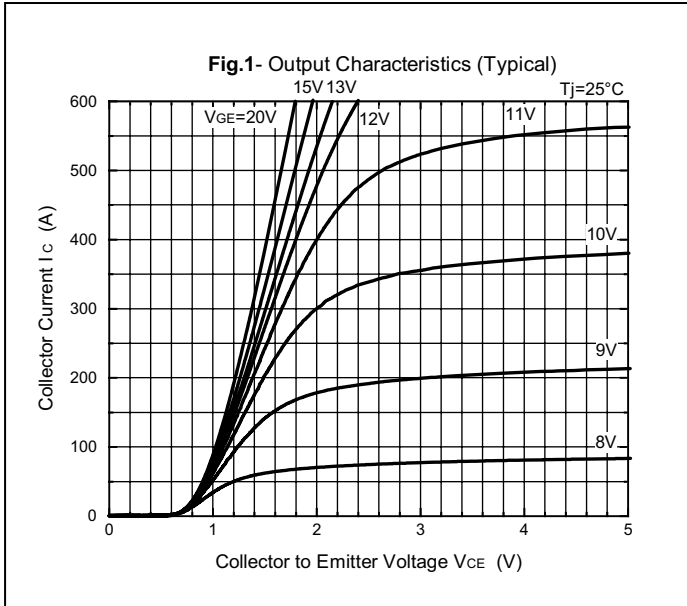
□ 電気的特性 : **ELECTRICAL CHARACTERISTICS** (at $T_J=25^\circ\text{C}$ unless otherwise specified)

Characteristic		Symbol	Test Condition	Min.	Typ.	Max.	Unit	
IGBT	コレクタ遮断電流 Collector-Emitter Cut-Off Current	ICES	$V_{CE}=650V, V_{GE}=0V$	—	—	1.0	mA	
	ゲート漏れ電流 Gate-Emitter Leakage Current	IGES	$V_{GE}=\pm 20V, V_{CE}=0V$	—	—	1.0	μA	
	コレクタ・エミッタ間飽和電圧 Collector-Emitter Saturation Voltage	$V_{CE(sat.)}$	$I_C=300A, V_{GE}=15V$ (chip level)	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$ $T_J=150^\circ\text{C}$	— — —	1.45 1.65 1.70	1.95 — —	V
	ゲートしきい値電圧 Gate-Emitter Threshold Voltage	$V_{GE(th)}$	$V_{CE}=10V, I_C=6mA$		4.8	—	7.0	V
	入力容量 Input Capacitance	C_{ies}	$V_{CE}=25V, V_{GE}=0V, f=1MHz$		—	25.0	—	nF
	出力容量 Output Capacitance	C_{oes}			—	1.0	—	
	帰還容量 Reverse Transfer Capacitance	C_{res}			—	0.8	—	
	ゲート電荷量 Gate Charge	Qg	$V_{CC}=300V, I_C=300A, V_{GE}=-15\sim+15V$		—	2550	—	nC
	スイッチング時間 Switching Time	上昇時間 Rise Time	tr	$V_{CC}=300V, L_s=20nH$	—	90	—	ns
		ターンオン遅延時間 Turn-on Delay Time	td(on)	$I_C=300A$ Inductive Load	—	220	—	
下降時間 Fall Time		tf	$R_G=3.6\Omega$	—	95	—		
ターンオフ遅延時間 Turn-off Delay Time		td(off)	$V_{GE}=\pm 15V$ $T_J=150^\circ\text{C}$	—	400	—		
FWD	順電圧 Peak Forward Voltage	V_F	$I_F=300A, V_{GE}=0V$ (chip level)	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$ $T_J=150^\circ\text{C}$	— — —	1.70 1.60 1.55	2.20 — —	V
	逆回復時間 Reverse Recovery Time	t _{rr}	$V_{CC}=300V, L_s=20nH$ $I_C=300A$ Inductive Load $R_G=3.6\Omega$ $V_{GE}=\pm 15V$ $T_J=150^\circ\text{C}$		—	175	—	ns
内部配線抵抗 Internal Lead Resistance		$R_{CC+EE'}$	主端子—チップ間 / 1素子 Main Terminal - Chip / Per 1 Arm		—	—	0.6	m Ω
内部インダクタンス Stray Inductance		LSCE	メイン端子3—2間 Main Terminal 3 - Main Terminal 2		—	27	—	nH

□ 熱的特性 : **THERMAL CHARACTERISTICS**

Characteristic		Symbol	Test Condition	Min.	Typ.	Max.	Unit
熱抵抗 Thermal Resistance	IGBT	$R_{th(j-c)}$	Junction to Case Per 1 Arm (T _c 測定点: チップ直下)	—	—	0.13	°C/W
	FWD			—	—	0.33	
接触熱抵抗 Thermal Resistance	IGBT	$R_{th(c-f)}$	Case to heatsink Per 1 Arm Paste=1W/(m ² °C)	—	0.05	—	
	FWD			—	0.10	—	

特性 : CHARACTERISTICS CURVES



□ 特性 : **CHARACTERISTICS CURVES**

